Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/773,038	HAJE ET AL.		
Examiner	Art Unit		
Devin Hanan	3745		

SEARCHED			
Class	Subclass	Date	Examiner
415	115		
	116-117		
	100		
	102-103		
416	198A	6/10/2005	DH
		<u>.</u>	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARC		")
	DATE	EXMR
consulted Ninh Nguyen on class 415 and 416	6/3/2005	
consulted Chris Verdier on class 415 and 416	6/8/2005	DH
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